

**IN THE CLAIMS:**

Please cancel claims 1, 7-8 and 11 without prejudice or disclaimer, and amend claims 2-3, 6, 9-10 and 12 as follows:

1. (Cancelled)
2. (Currently Amended) An image display device provided with an active-matrix substrate comprising:
  - an insulating substrate; and
  - a plurality of circuit regions fabricated on said insulating substrate and including at least a pixel section and a pixel-driving circuit section, each of said pixel section and said pixel-driving circuit section having a polycrystalline silicon semiconductor film,
  - wherein said plurality of circuit regions includes at least one pair of a first circuit region constituting a first circuit and a second circuit region constituting a second circuit,
  - all thin film transistors in said first circuit region flow currents through channels thereof in a first angular orientation,
  - all thin film transistors in said second circuit region flow currents through channels thereof in a second angular orientation, and
  - said first angular orientation is formed to be non-parallel with said second angular orientation.
3. (Currently Amended) An image display device ~~according to claim 1~~ provided with an active-matrix substrate comprising:
  - an insulating substrate; and
  - a plurality of circuit regions fabricated on said insulating substrate and including at least a pixel section and a pixel-driving circuit section, each of said pixel section and said pixel-driving circuit section having a polycrystalline silicon semiconductor film,
  - wherein at least one of said plurality of circuit regions has a first type of a thin film transistor and a second type of a thin film transistor, and

an angular orientation of a direction of a current flowing through a channel of said first type of a thin film transistor is formed to be non-parallel with an angular orientation of a direction of a current flowing through a channel of said second type of a thin film transistor,

wherein said plurality of circuit regions includes at least one pair of a first-type circuit region constituting a first circuit and a second-type circuit region constituting a second circuit,

all thin film transistors in said first-type circuit region flow currents through channels thereof in one angular orientation, and

angular orientations of currents flowing through channels of thin film transistors in said second-type circuit region are plural in number.

4. (Previously Presented) An image display device according to claim 3, wherein said one angular orientation is same in all of said first-type circuit regions included in said plurality of circuit regions.
5. (Original) An image display device according to claim 3, wherein, in said first-type circuit region, a peak-to-valley height difference of a surface of said channel, a source region and a drain region of said thin film transistors is equal to or smaller than 5 nm, and crystalline grains of said polycrystalline silicon semiconductor film are of a rectangular shape of 0.3  $\mu\text{m}$  to 2  $\mu\text{m}$  in width and 4  $\mu\text{m}$  or more in length; and  
in said second-type circuit region, an average crystalline grain diameter is 1  $\mu\text{m}$  or smaller and a peak-to-valley height difference of a surface is equal to or greater than 20 nm, in said channel, a source region and a drain region of said thin film transistors.
6. (Currently Amended) An image display device ~~according to claim 1~~ provided with an active-matrix substrate comprising:  
an insulating substrate; and  
a plurality of circuit regions fabricated on said insulating substrate and including at least a pixel section and a pixel-driving circuit section, each of said pixel section and said pixel-driving circuit section having a polycrystalline silicon semiconductor film,

wherein at least one of said plurality of circuit regions has a first type of a thin film transistor and a second type of a thin film transistor, and

an angular orientation of a direction of a current flowing through a channel of said first type of a thin film transistor is formed to be non-parallel with an angular orientation of a direction of a current flowing through a channel of said second type of a thin film transistor,

wherein said thin film transistors of said first and second types are fabricated from polycrystalline silicon films having plural kinds of surface configurations, and

said thin film transistors constituting at least one of said plurality of circuit regions are such that a peak-to-valley height difference of a surface of said channel, a source region and a drain region of said thin film transistors is equal to or smaller than 5 nm, and crystalline grains of said polycrystalline silicon film are of a rectangular shape of 0.3  $\mu\text{m}$  to 2  $\mu\text{m}$  in width and 4  $\mu\text{m}$  or more in length.

7-8. (Cancelled)

9. (Currently Amended) An image display device according to claim 5 ~~provided with an active matrix substrate having~~

~~a plurality of circuit regions fabricated on one insulating substrate and including at least a pixel section and a pixel driving circuit section, each of said pixel section and said pixel driving circuit section having thin film transistors formed of polycrystalline silicon films,~~

wherein in said polycrystalline silicon films in a channel, a source region and a drain region of said thin film transistors constituting said pixel section,

an average crystalline grain diameter is 1  $\mu\text{m}$  or smaller, and

a peak-to-valley height difference of a surface is equal to or greater than 20 nm, ~~;~~ and

wherein in at least one of said plurality of circuit regions excluding said pixel section,

crystalline grains of said polycrystalline silicon films are of a rectangular shape of 0.3  $\mu\text{m}$  to 2  $\mu\text{m}$  in width and 4  $\mu\text{m}$  or more in length in a channel, a source region and a drain region of said thin film transistors, and

a peak-to-valley height difference of a surface of said channel, said source region and said drain region of said thin film transistors is equal to or smaller than 5 nm.

10. (Currently Amended) An image display device according to claim [[9]]5, wherein said thin film transistors have plural kinds of gate insulating materials and plural kinds of thickness in ones of said plurality of circuit regions excluding said one of said plurality of circuit regions constituting said pixel section.
11. (Cancelled)
12. (Currently Amended) An image display device according to claim [[9]]5, wherein a level shifter, a sampling switch circuit and a buffer circuit constituting a pixel-driving circuit are fabricated in ones of said plurality of circuit regions excluding said one of said plurality of circuit regions constituting said pixel section,  
said channel, said source region and said drain region of said thin film transistors constituting said pixel-driving circuit are formed of polycrystalline silicon films having an average crystalline grain diameter of 1  $\mu\text{m}$  or smaller and a peak-to-valley height difference of a surface equal to or greater than 20 nm, and  
said channel, said source region and said drain region of said thin film transistors constituting at least one of said circuits excluding said level shifter and said sampling switch circuit are formed of polycrystalline silicon films having crystalline grains of a rectangular shape of 0.3  $\mu\text{m}$  to 2  $\mu\text{m}$  in width and 4  $\mu\text{m}$  or more in length and a peak-to-valley height difference of a surface equal to or smaller than 5 nm.